Power MOSFET

30 V, 50 A, Single N-Channel, μ8FL

Features

- Small Footprint (3.3 x 3.3 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- This is a Pb-Free Device

Applications

- DC-DC Converters
- High Side Switching

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Param	Symbol	Value	Unit		
Drain-to-Source Voltage	V_{DSS}	30	V		
Gate-to-Source Voltage	V_{GS}	±20	V		
Continuous Drain		T _A = 25°C	Ι _D	12.6	Α
Current R _{θJA} (Note 1)		T _A = 85°C]	9.1	
Power Dissipation $R_{\theta JA}$ (Note 1)	T _A = 25°C		P _D	2.1	W
Continuous Drain		T _A = 25°C	I _D	17.5	Α
Current $R_{\theta JA} \le 10 \text{ s}$ (Note 1)		T _A = 85°C		12.6	
Power Dissipation $R_{\theta JA} \le 10 \text{ s (Note 1)}$	Steady	T _A = 25°C	P _D	4.0	W
Continuous Drain	State	T _C = 25°C	Ι _D	7.1	Α
Current R _{θJA} (Note 2)		T _C = 85°C]	5.1	
Power Dissipation R _{0JA} (Note 2)		T _C = 25°C	P _D	0.66	W
Continuous Drain		T _C = 25°C	Ι _D	50	Α
Current R _{θJC} (Note 1)		T _C = 85°C		36	
Power Dissipation R ₀ JC (Note 1)		T _C = 25°C	P _D	32.9	W
Pulsed Drain Current	T _A = 25°	C, t _p = 10 μs	I _{DM}	150	Α
Current Limited by Pkg.	T _A	= 25°C	I _{DmaxPkg}	90	Α
Operating Junction and S	T _J , T _{stg}	-55 to +150	°C		
Source Current (Body Did	I _S	33	Α		
Drain to Source DV/DT	dV/dt	6	V/ns		
Single Pulse Drain-to-So $(T_J = 25^{\circ}C, V_{DD} = 50 \text{ V}, \text{V}_{L} = 25 \text{ A}_{pk}, \text{ L} = 0.1 \text{ mH, F}$	E _{AS}	31	mJ		
Lead Temperature for So (1/8" from case for 10 s)	T _L	260	°C		

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- 1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.

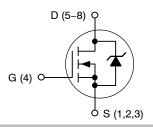


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http://onsemi.com

V _{(BR)DSS} R _{DS(on)} MAX		I _D MAX
30 V	10.5 mΩ @ 10 V	50 A
	17.5 mΩ @ 4.5 V	30 A

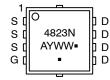
N-Channel MOSFET





WDFN8 (μ8FL) CASE 511AB FLAT LEAD

MARKING DIAGRAM



4823N = Specific Device Code A = Assembly Location Y = Year

Y = Year
WW = Work Week
Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTTFS4823NTAG	WDFN8 (Pb-Free)	1500/Tape & Reel
NTTFS4823NTWG	WDFN8 (Pb-Free)	5000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	3.8	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{ heta JA}$	59.4	
Junction-to-Ambient - Steady State (Note 4)	$R_{ heta JA}$	190.2	
Junction–to–Ambient $-$ (t \leq 10 s) (Note 3)	$R_{ heta JA}$	31.1	

ELECTRICAL CHARACTERISTICS (T₁ = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS					•	•	·
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V, } I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				25		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 24 V	$T_J = 25^{\circ}C$ $T_J = 125^{\circ}C$			1.0	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} =	±20 V			±100	nA
ON CHARACTERISTICS (Note 5)	I.				1		
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 2$	250 μΑ	1.5	1.9	2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				6		mV/°C
Drain-to-Source On Resistance	R _{DS(on)} V _{GS} = 10 V to 11.5 V	101/1 1151/	I _D = 20 A		8.1	10.5	mΩ
		I _D = 10 A		8.0			
		\\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	I _D = 20 A		13.5	17.5	
		V _{GS} = 4.5 V	I _D = 10 A		13		
Forward Transconductance	9 _{FS}	V _{DS} = 1.5 V, I _D = 20 A			34		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{iss}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 12 V			750		pF
Output Capacitance	C _{oss}				175		
Reverse Transfer Capacitance	C _{rss}				100		
Total Gate Charge	Q _{G(TOT)}				6.5	9.0	nC
Threshold Gate Charge	Q _{G(TH)}	\	\/ I 00 A		0.8		
Gate-to-Source Charge	Q _{GS}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15$	v, I _D = 20 A		2.5		
Gate-to-Drain Charge	Q_{GD}				2.9		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 11.5 V, V _{DS} = 15 V, I _D = 20 A			15		nC
SWITCHING CHARACTERISTICS (No	ote 6)						
Turn-On Delay Time	t _{d(on)}	V_{GS} = 4.5 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			12		ns
Rise Time	t _r				22		7
Turn-Off Delay Time	t _{d(off)}				14		7
Fall Time	t _f				4		7

^{5.} Pulse Test: pulse width = 300 μ s, duty cycle \leq 2%.

Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

^{6.} Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTIC	S (Note 6)		•		•		
Turn-On Delay Time	t _{d(on)}				7.0		ns
Rise Time	t _r	V _{GS} = 11.5 V, V _{DS}	= 15 V,		18		
Turn-Off Delay Time	t _{d(off)}	$V_{GS} = 11.5 \text{ V}, V_{DS}$ $I_{D} = 15 \text{ A}, R_{G} =$	3.0 Ω		20		
Fall Time	t _f	1			2.0		
DRAIN-SOURCE DIODE CHARA	CTERISTICS						
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$		0.93	1.1	V
		$I_S = 20 \text{ A}$	T _J = 125°C		0.83		
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V},$ $d_{IS}/d_{t} = 100 \text{ A}/\mu\text{s},$ $I_{S} = 20 \text{ A}$			13		ns
Charge Time	t _a				7.5		
Discharge Time	t _b				5.5		
Reverse Recovery Charge	Q _{RR}				4.0		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L _S				0.38		nH
Drain Inductance	L _D	T _A = 25°C			0.054		
Gate Inductance	L _G				1.3		
Gate Resistance	R _G				0.65	2.0	Ω

^{5.} Pulse Test: pulse width = 300 μs, duty cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

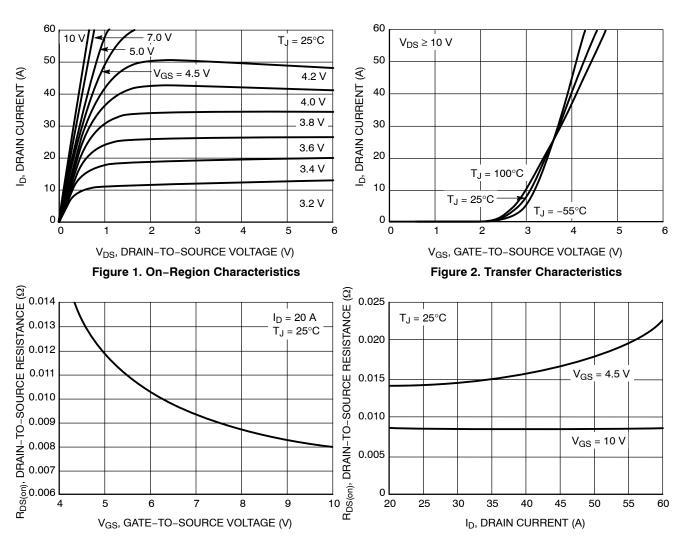


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage

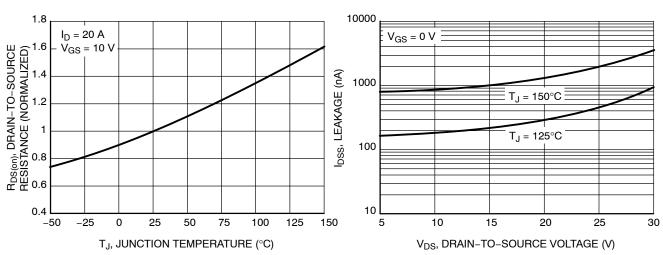


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

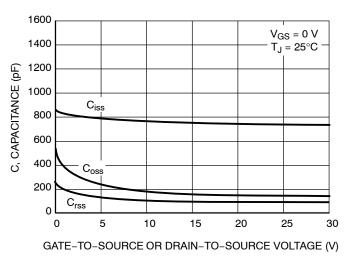


Figure 7. Capacitance Variation

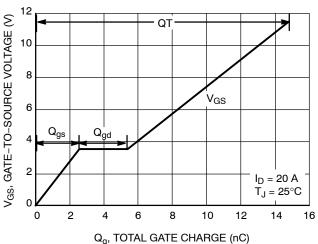


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

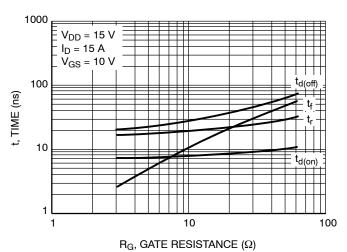


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

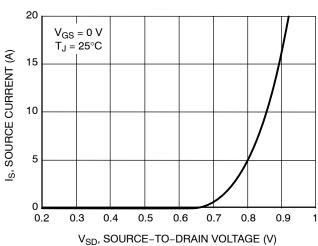


Figure 10. Diode Forward Voltage vs. Current

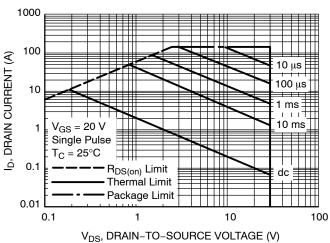


Figure 11. Maximum Rated Forward Biased Safe Operating Area

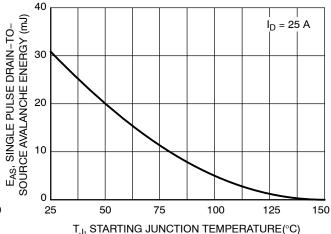
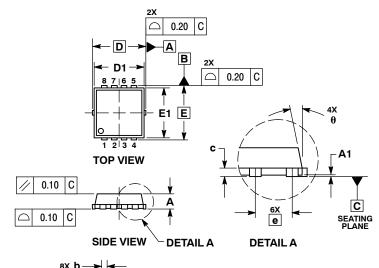


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

PACKAGE DIMENSIONS

WDFN8 3.3x3.3, 0.65P CASE 511AB-01 **ISSUE B**

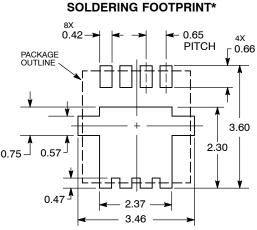


- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- DIMENSIONING AND TOLERANCING FER ASINE 114.3M, CONTROLLING DIMENSION: MILLIMETERS.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS.

	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.70	0.75	0.80	0.028	0.030	0.031	
A1	0.00		0.05	0.000		0.002	
b	0.23	0.30	0.40	0.009	0.012	0.016	
С	0.15	0.20	0.25	0.006	0.008	0.010	
D	3.30 BSC			0.130 BSC			
D1	2.95	3.05	3.15	0.116	0.120	0.124	
D2	1.98	2.11	2.24	0.078	0.083	0.088	
E		3.30 BSC	;	0.130 BSC			
E1	2.95	3.05	3.15	0.116	0.120	0.124	
E2	1.47	1.60	1.73	0.058	0.063	0.068	
е		0.65 BSC	;	0.026 BSC			
G	0.30	0.41	0.51	0.012	0.016	0.020	
K	0.64		-	0.025			
L	0.30	0.43	0.56	0.012	0.017	0.022	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
М	1.40	1.50	1.60	0.055	0.059	0.063	
θ	0 °		12 °	0 °		12 °	

0.10 С Α В Ф 0.05 С

BOTTOM VIEW



DIMENSION: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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